

A Frequency-Lock System for Improved Quartz Crystal Oscillator Performance

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Abstract—The intrinsic noise of the best quartz crystal resonators is significantly less than the noise observed in oscillators employing these resonators. Several problem areas common to traditional designs are pointed out and a new approach is suggested for their solution. Two circuits are described which frequency lock a spectrally pure quartz crystal oscillator to an independent quartz crystal resonator. The performance of the composite system is predicted based on the measured performance of its components.

INTRODUCTION

IN RECENT YEARS, tremendous advances have been made in the manufacture of ultrastable quartz resonators. Moreover, it is quite likely that further improvements in this area will be made within the next two years. Especially promising are the SC cut, TTC cut, and the various electrodeless AT and SC cut resonators [1]–[4]. The purpose of this paper is to point out some problems in the electronics design of traditional quartz-crystal oscillators and to introduce some new circuit concepts which will significantly reduce these problems.

PROBLEM AREAS

The traditional circuitry for a crystal-controlled oscillator uses the resonator inside of the oscillating loop as shown schematically in Fig. 1. A necessary condition for oscillation

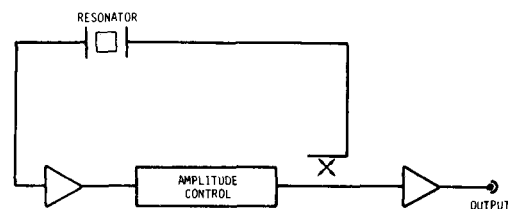


Fig. 1. Traditional quartz-crystal-controlled oscillator.

is that the phase shift around the loop be a multiple of 2π rad. A small phase fluctuation ϕ away from this state causes a fractional frequency change

$$y = \Delta v/v = \phi/2Q$$

where Q is the loaded quality factor of the resonator. In order to achieve a long-term fractional frequency stability of 10^{-13} with a resonator having a loaded Q of 2.5×10^6 , the phase variations must be less than 5×10^{-7} rad. For standard coaxial cable with phase stability of approximately 100 ppm/°C, this corresponds to a temperature change of 1°C over a 5 cm length. Since nearly all components are phase sensitive, it is doubtful that the required stability around the oscillating loop can be achieved for extended periods of time.

The phase shift around the loop is also perturbed by output loading and pickup of stray signals. For example, a 20-percent change in the load resistance from the matched condition produces a reflected signal back into the oscillator

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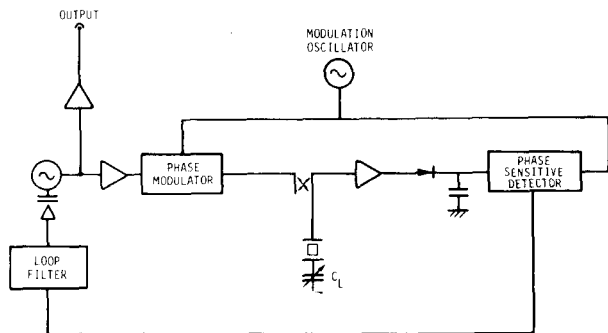


Fig. 3. Phase modulation system for locking an oscillator to a passive quartz resonator.

asynchronously realize a frequency stability of 10^{-13} it is necessary to average for 3×10^5 s or about 3 days. The latter problem may be overcome by phase-locking a oscillator 2 to oscillator 1 with a synchronous PLL. The loop filter for the PLL must average the phase difference between oscillators 1 and 2 over complete cycles of the modulation frequency in order to cancel most of the unwanted phase modulation.

This system appears to be quite complex and costly. A simpler system can be implemented which is based upon the same general principles, but which overcomes the two deficiencies just described. The simplified block diagram is shown in Fig. 3. Once again, the crystal dissipates about 10^{-7} W, C_L is approximately 250 pF and extensive use is made of low-noise isolation amplifiers. One major difference from the previous circuit is that the required modulation is accomplished by phase modulating the oscillator output rather than frequency modulating the oscillator itself. Consequently, a system output can be provided which is uncontaminated by the internal modulation frequency. The second significant difference is that the diode detector produces the modulation envelope of the signal which is reflected from the resonator rather than the signal transmitted through it. Thus the modulation frequency can greatly exceed the crystal bandwidth. The signal generated by this technique is proportional to the imaginary part of the reflection coefficient of the resonator which is, itself, linearly proportional to the frequency deviation from the center of the resonance. The heuristic explanation of this behavior is that the carrier reflects from the resonance but the sidebands are so far removed from the center that they effectively reflect from a short circuit (more detail is given in [7]). The advantage of the high modulation frequency which is possible in this system (for example, 200 Hz) is that the attack time of the frequency lock loop can be decreased by a factor of 200 compared to the case of the circuit in Fig. 2. This would make it possible to use one inexpensive component oscillator rather than the two high-quality oscillators needed in the previous example.

EXPECTED PERFORMANCE

The performance expected from the system suggested in Fig. 3 can be estimated from the measurements on the various components. Curve A of Fig. 4 shows the measured

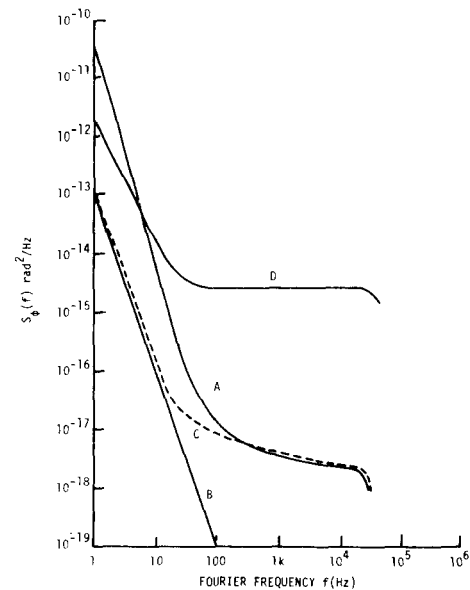


Fig. 4. Spectral density of phase noise for (A) a commercial high power 5 MHz oscillator, (B) a quartz crystal resonator measured passively, (C) the proposed system for locking A to B with 100 Hz unity gain frequency, and (D) a commercial low-power quartz-crystal oscillator.

spectral density of phase fluctuations $S_\phi(f)$ for a commercially available high power 5-MHz oscillator that would be suitable for the local oscillator. Note that its phase noise rises very rapidly close to the carrier, due primarily to the high drive level.

The frequency stability of commercial high-quality AT-cut quartz resonators has been measured using a passive phase bridge technique which has been previously discussed [10]. By evaluating three or more resonators in various pairs one can independently determine the stability of each resonator. Curve B of Fig. 4 shows the equivalent $S_\phi(f)$ for the best two of the four samples tested.

The use of a frequency-lock loop with a second-order loop filter (see, for example, [11]) should make it possible to achieve a system output with the phase noise shown in curve C of Fig. 4.

For comparison, the spectral density of phase for a commercial high quality, low-power 5-MHz quartz controlled oscillator is shown in curve D of Fig. 4. Note that the curve C, the system output, is significantly superior to curve D at all Fourier frequencies.

The corresponding time domain stabilities can be calculated from Fig. 4, and, assuming that the contribution to the phase noise from spurious pickup is insignificant, are given in Fig. 5. Again, note that the system output, curve C, is projected to yield excellent short term stability and long term stability. The frequency stability of such a system should exceed that of all available commercial standards for measurement times below 1000 s.

The frequency stability beyond 1000 s cannot be estimated from present measurements on the crystal resonators. However, from the above analysis we expect that the frequency stability of such a system should be superior to any present crystal-controlled oscillator, and further, that as

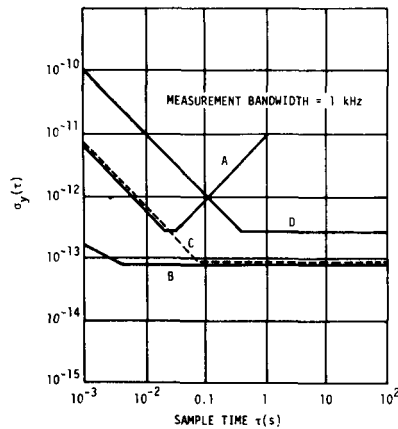


Fig. 5. The computed two-sample deviations corresponding to curves A, B, C, D of Fig. 4.

new quartz resonator types become available frequency drift and other long term frequency changes can be kept below 10^{-12} /week. The new crystal resonators are likely to exhibit much better turn-off turn-on retrace, lower hysteresis due to temperature cycling, and much lower acceleration sensitivity [2], [3].

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